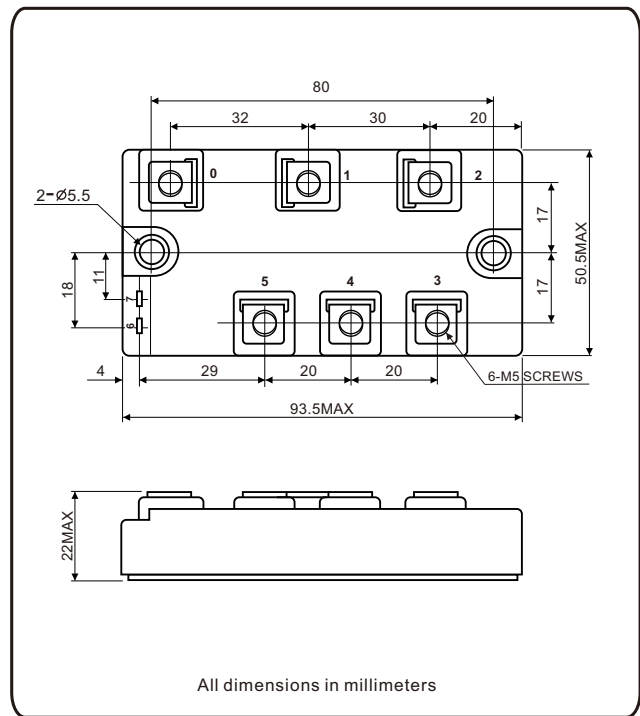
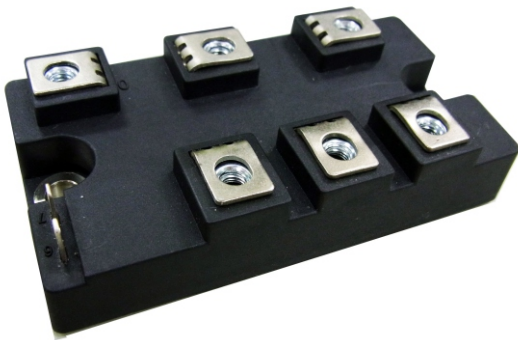


## Three-Phase Bridge + Thyristor, 75A

### MTPT7508 Thru MTPT7516



### FEATURES

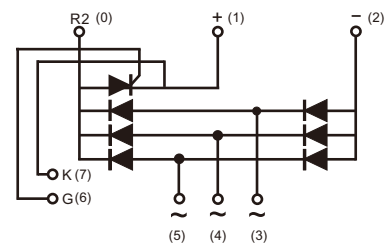
- UL recognition file number E320098
- Three-phase bridge and a thyristor
- High surge current capability
- Low thermal resistance
- Compliant to RoHS
- Isolation voltage up to 2500V
- Glass passivated chip junction

### Applications

- Inverter for AC or DC motor control
- Current stabilized power supply
- Switching power supply

### ADVANTAGE

- International standard package  
Epoxy meets UL 94 V-O flammability rating
- Small volume, light weight
- Small thermal resistance
- Weight: 210g (7.4 ozs)



PRIMARY CHARACTERISTICS	
$I_{F(AV)}$	75A
$V_{RRM}$	800V to 1600V
$I_{FSM}/I_{TSM}$	750A/920A
$I_R$	20 $\mu$ A
$V_{FM}/V_{TM}$	1.3V/1.6V
$T_{J\ max.}$	150°C

### ⊙ Maximum Ratings for Diodes

MAJOR RATINGS AND CHARACTERISTICS (T <sub>A</sub> = 25°C unless otherwise noted)					
PARAMETER	SYMBOL	MTPT75			UNIT
		08	12	16	
Maximum repetitive peak reverse voltage	V <sub>RRM</sub> /V <sub>RRM</sub>	800	1200	1600	V
Peak reverse non-repetitive voltage	V <sub>RSM</sub>	900	1300	1700	V
Output DC current three-phase full wave, T <sub>c</sub> = 100°C	I <sub>O</sub>	75			A
Peak forward surge current single sine-wave superimposed on rated load	I <sub>FSM</sub>	750			A
Rating (non-repetitive, for t greater than 1 ms and less than 8.3 ms) for fusing	I <sup>2</sup> t	2810			A <sup>2</sup> s
Operating junction temperature range	T <sub>J</sub>	-40 to 150			°C
Storage temperature range	T <sub>STG</sub>	-40 to 125			°C
Thermal Impedance, junction to case	R <sub>thJC</sub>	0.25			°C/W
Thermal Impedance, case to heatsink	R <sub>thCS</sub>	0.10			°C/W

ELECTRICAL CHARACTERISTICS (T <sub>A</sub> = 25°C unless otherwise noted)						
PARAMETER	TEST CONDITIONS	SYMBOL	MTPT75			UNIT
			08	12	16	
Maximum instantaneous forward drop per diode	I <sub>F</sub> = 75A	V <sub>F</sub>	1.3			V
Maximum reverse DC current at rated DC blocking voltage per diod	T <sub>A</sub> = 25°C	I <sub>R</sub>	20			μA
	T <sub>A</sub> = 150°C		6			mA

### ⊙ Maximum Ratings for Thyristor

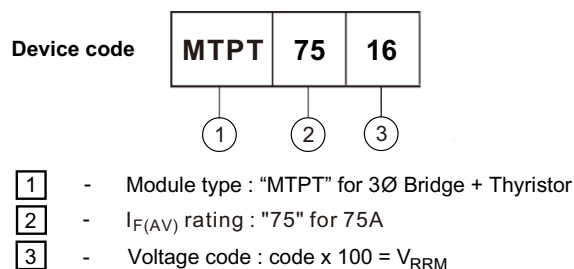
FORWARD CONDUCTION					
PARAMETER	SYMBOL	TEST CONDITIONS		VALUES	UNITS
Maximum average on-state current at case temperature	I <sub>T(AV)</sub>	180° conduction, half sine wave ,50Hz		75	A
				85	°C
Maximum peak, one-cycle, on-state non-repetitive surge current	I <sub>TSM</sub>	t = 10 ms	No voltage reappplied	920	A
		t = 8.3 ms		965	
		t = 10 ms	100% V <sub>RRM</sub> reappplied	775	
		t = 8.3 ms		810	
Maximum I <sup>2</sup> t for fusing	I <sup>2</sup> t	t = 10 ms	No voltage reappplied	4230	A <sup>2</sup> s
		t = 8.3 ms		3865	
		t = 10 ms	100% V <sub>RRM</sub> reappplied	3005	
		t = 8.3 ms		2725	
Maximum I <sup>2</sup> √t for fusing	I <sup>2</sup> √t	t = 0.1 ms to 10 ms, no voltage reappplied		42.3	kA <sup>2</sup> √s
Maximum on-state voltage drop	V <sub>TM</sub>	I <sub>TM</sub> = 225A, T <sub>J</sub> = 25 °C, 180° conduction		1.6	V
Maximum holding current	I <sub>H</sub>	Anode supply = 6 V, initial I <sub>T</sub> = 30 A, T <sub>J</sub> = 25 °C		150	mA
Maximum latching current	I <sub>L</sub>	Anode supply = 6 V Gate pulse: 10 V, 100 μs, T <sub>J</sub> = 25 °C		400	

SWITCHING					
PARAMETER	SYMBOL	TEST CONDITIONS		VALUES	UNITS
Typical delay time	t <sub>d</sub>	T <sub>J</sub> = 25 °C ,gate current = 1A dI <sub>g</sub> /dt = 1 A/μs V <sub>d</sub> = 0.67 V <sub>DRM</sub>		1	μs
Typical rise time	t <sub>r</sub>			2	
Typical tum-off time	t <sub>q</sub>	I <sub>TM</sub> = 300A ; dI/dt = 15 A/μs ; T <sub>J</sub> = T <sub>J</sub> maximum, V <sub>R</sub> = 50V ; dV/dt = 20V/μs ; gate 0V ,100Ω		50 to 150	

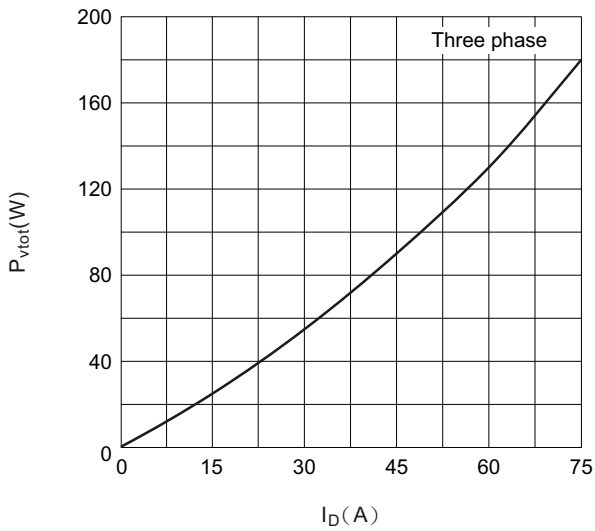
BLOCKING				
PARAMETER	SYMBOL	TEST CONDITIONS	VALUES	UNITS
Maximum peak reverse and off-state leakage current	$I_{RRM}$ , $I_{DRM}$	$T_J = 125\text{ }^\circ\text{C}$	20	mA
RMS isolation Voltage	$V_{ISO}$	50 Hz, circuit to base, all terminals shorted, $25\text{ }^\circ\text{C}$ , 60s	2500	V
Critical rate of rise of off-state voltage	dV/dt	$T_J = T_J$ maximum, exponential to 67 % rated $V_{DRM}$	500	V/ $\mu\text{s}$

TRIGGERING				
PARAMETER	SYMBOL	TEST CONDITIONS	VALUES	UNITS
Maximum peak gate power	$P_{GM}$	$t_p \leq 5\text{ ms}$ , $T_J = T_J$ maximum	15	W
Maximum average gate power	$P_{G(AV)}$	$f = 50\text{ Hz}$ , $T_J = T_J$ maximum	5	
Maximum peak gate current	$I_{GM}$	$t_p \leq 5\text{ ms}$ , $T_J = T_J$ maximum	3	A
Maximum peak negative gate voltage	$-V_{GT}$		10	V
Maximum required DC gate voltage to trigger	$V_{GT}$	$T_J = 25\text{ }^\circ\text{C}$	Anode supply = 6V, resistive load; $R_a = 1\ \Omega$	
Maximum required DC gate current to trigger	$I_{GT}$			150
Maximum gate voltage that will not trigger	$V_{GD}$	$T_J = T_J$ maximum, 67% $V_{DRM}$ applied	0.25	V
Maximum gate current that will not trigger	$I_{GD}$		10	mA
Maximum rate of rise of turned-on current	dI/dt	$T_J = 125\text{ }^\circ\text{C}$ , $V_D = 0.5V_{DRM}$ , $I_G = 100\text{ mA}$ , $dI_G/dt = 0.1\text{ A}/\mu\text{s}$	150	A/ $\mu\text{s}$

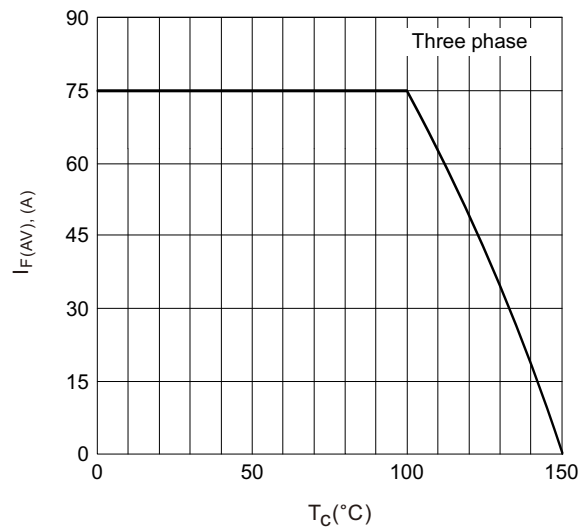
THERMAL AND MECHANICAL SPECIFICATIONS				
PARAMETER	SYMBOL	TEST CONDITIONS	VALUES	UNITS
junction operating and storage temperature range	$T_J$ , $T_{stg}$		- 40 to 125	$^\circ\text{C}$
Maximum thermal resistance, junction to case per junction	$R_{thJC}$	DC operation	0.40	$^\circ\text{C}/\text{W}$
Typical thermal resistance, case to heatsink per module	$R_{thCS}$	Mounting surface, smooth , flat and greased	0.10	
Mounting torque $\pm 10\%$ to heatsink, M5 to terminal, M5		A mounting compound is recommended and the torque should be rechecked after a period of about 3 hours to allow for the spread of the compound.	3	N.m
			3	
Approximate weight			210	g
			7.4	oz.



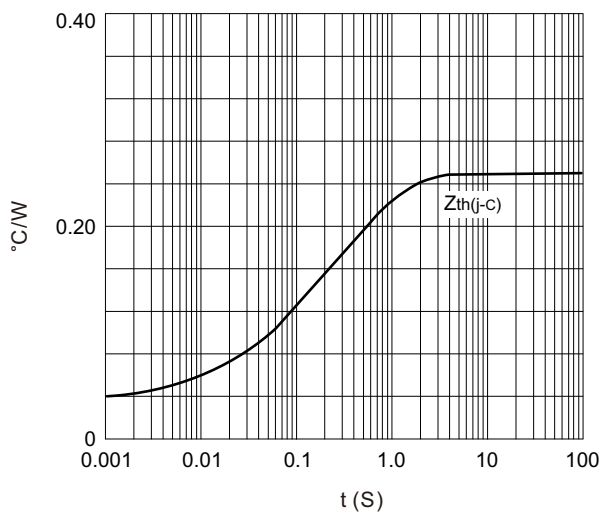
**Fig.1 Power dissipation (For Diodes)**



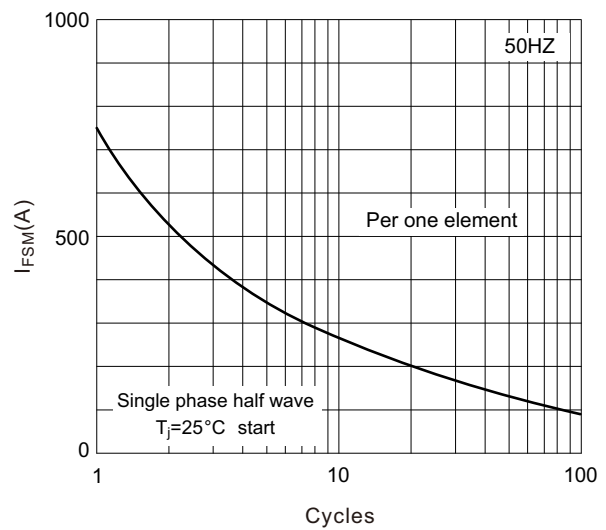
**Fig.2 Forward current derating curve (For Diodes)**



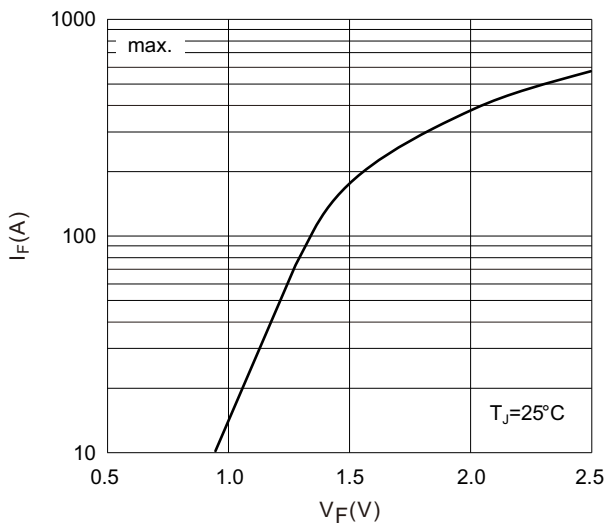
**Fig.3 Transient thermal impedance (For Diodes)**



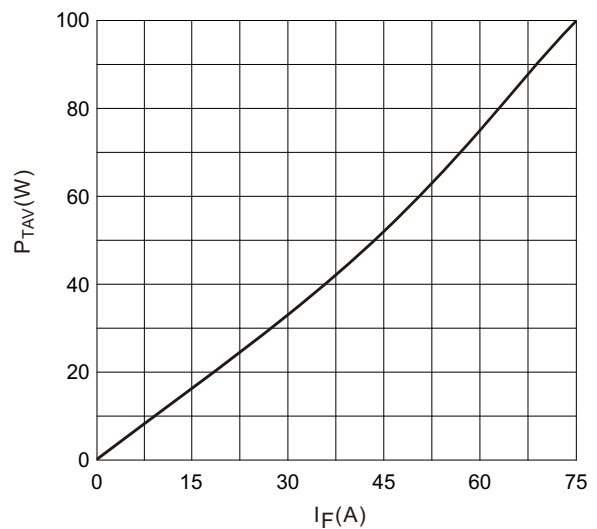
**Fig.4 Max non-repetitive forward surge current (For Diodes)**



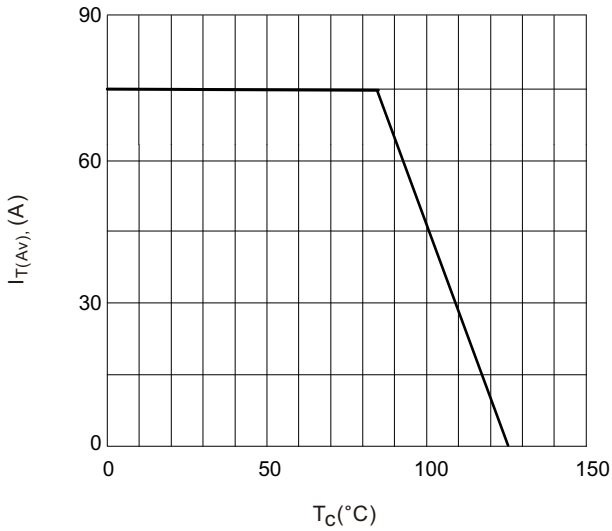
**Fig.5 Forward characteristics (For Diodes)**



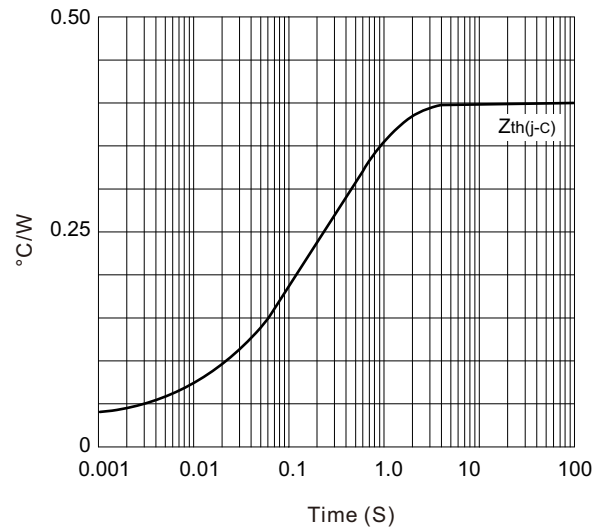
**Fig.6 SCR power dissipation**



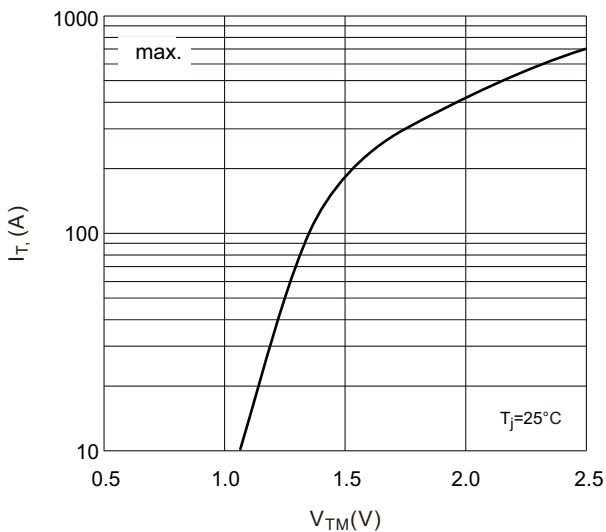
**Fig.7 SCR forward current derating curve**



**Fig.8 SCR transient thermal impedance**



**Fig.9 SCR forward characteristics**



**Fig.10 Gate trigger characteristics**

